

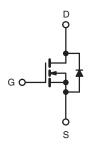
# SWP3N80A-VB Datasheet **Power MOSFET**

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	850				
R <sub>DS(on)</sub> (Ω)	$V_{GS} = 10 V$	2.7			
Q <sub>g</sub> (Max.) (nC)	78				
Q <sub>gs</sub> (nC)	9.6				
Q <sub>gd</sub> (nC)	45				
Configuration	Single				

#### **FEATURES**

- Halogen-free According to IEC 61249-2-21 Definition
- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- · Fast Switching
- · Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC





N-Channel MOSFET

<b>ABSOLUTE MAXIMUM RATINGS</b> ( $T_C = 25 \text{ °C}$ , unless otherwise noted)						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V <sub>DS</sub>	850	v	
Gate-Source Voltage			V <sub>GS</sub>	± 20	- V	
Continuous Drain Current	V + 10 V	T <sub>C</sub> = 25 °C	- I <sub>D</sub>	4.1		
	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 100 °C		2.6	А	
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	16		
Linear Derating Factor				1.0	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	260	mJ	
Avalanche Current <sup>a</sup>			I <sub>AR</sub>	4.1	А	
Repetitive Avalanche Energy <sup>a</sup>			E <sub>AR</sub>	13	mJ	
Maximum Power Dissipation	m Power Dissipation $T_{\rm C} = 25 ^{\circ}{\rm C}$			125	W	
Peak Diode Recovery dV/dt <sup>c</sup>			dV/dt	2.0	V/ns	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature)	for	10 s		300 <sup>d</sup>	1	
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
Mounting Torque				1.1	N · m	

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b.  $V_{DD} = 50 \text{ V}$ , starting  $T_J = 25 \text{ °C}$ , L = 29 mH,  $R_g = 25 \Omega$ ,  $I_{AS} = 4.1 \text{ A}$  (see fig. 12). c.  $I_{SD} \le 4.1 \text{ A}$ , dl/dt  $\le 100 \text{ A/}\mu\text{s}$ ,  $V_{DD} \le 600 \text{ V}$ ,  $T_J \le 150 \text{ °C}$ . d. 1.6 mm from case.



THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	-	62		
Case-to-Sink, Flat, Greased Surface	R <sub>thCS</sub>	-	0.50	-	°C/W	
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	-	1.0		

#### Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static						•	
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA		850	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	Reference to 25 °C, I <sub>D</sub> = 1 mA		0.90	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μA		-	4.0	V
Gate-Source Leakage	I <sub>GSS</sub>		V <sub>GS</sub> = ± 20 V	-	-	± 100	nA
	I <sub>DSS</sub>	V <sub>DS</sub> = 800 V, V <sub>GS</sub> = 0 V		-	-	100	
Zero Gate Voltage Drain Current		V <sub>DS</sub> = 640 V	′, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	-	-	500	μA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 2.5 A <sup>b</sup>	-	2.7	-	Ω
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub> =	100 V, I <sub>D</sub> = 2.5 A	2.5	-	-	S
Dynamic							•
Input Capacitance	C <sub>iss</sub>		$V_{GS} = 0 V,$	-	1300	-	pF
Output Capacitance	C <sub>oss</sub>		$V_{DS} = 25 V,$	-	310	-	
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1	.0 MHz, see fig. 5	-	190	-	
Total Gate Charge	Qg			-	-	78	<u> </u>
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 10 V	$V_{GS} = 10 \text{ V}$ $I_D = 4.1 \text{ A}, V_{DS} = 400 \text{ V},$ see fig. 6 and 13 <sup>b</sup>		-	9.6	nC
Gate-Drain Charge	Q <sub>gd</sub>		see lig. o and to	-	-	45	1
Turn-On Delay Time	t <sub>d(on)</sub>	$V_{DD}$ = 400 V, $I_D$ = 4.1 A, $R_g$ = 12 $\Omega,R_D$ = 95 $\Omega,see$ fig. $10^b$		-	12	-	- ns
Rise Time	t <sub>r</sub>			-	33	-	
Turn-Off Delay Time	t <sub>d(off)</sub>			-	82	-	
Fall Time	t <sub>f</sub>			-	30	-	
Internal Drain Inductance	L <sub>D</sub>		Between lead, 6 mm (0.25") from		4.5	-	
Internal Source Inductance	L <sub>S</sub>	package and center of die contact		-	7.5	-	- nH
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	4.1	A
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	16	
Body Diode Voltage	$V_{SD}$	$T_J = 25 \ ^\circ C, \ I_S = 4.1 \ A, \ V_{GS} = 0 \ V^b$		-	-	1.8	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	$T_J = 25 \text{ °C}, I_F = 4.1 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}^{b}$		-	480	720	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	1.8	2.7	nC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S$ and $L_D$				L <sub>D</sub> )	

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width  $\leq$  300 µs; duty cycle  $\leq$  2 %.





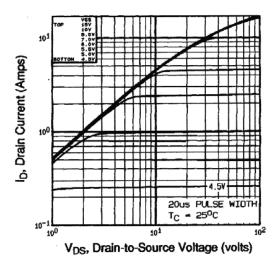


Fig. 1 - Typical Output Characteristics, T<sub>C</sub> = 25 °C

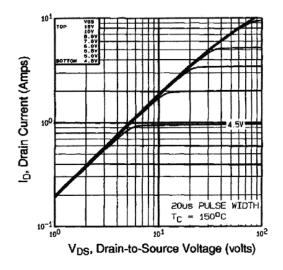


Fig. 2 - Typical Output Characteristics, T<sub>C</sub> = 150 °C

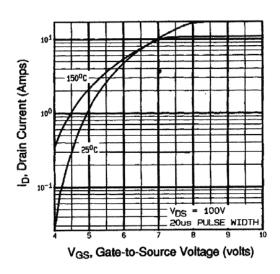


Fig. 3 - Typical Transfer Characteristics

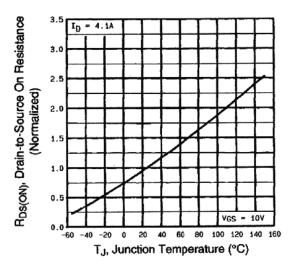


Fig. 4 - Normalized On-Resistance vs. Temperature



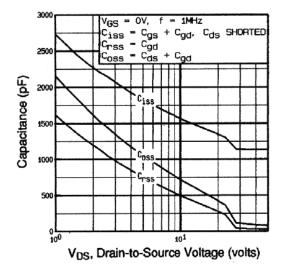


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

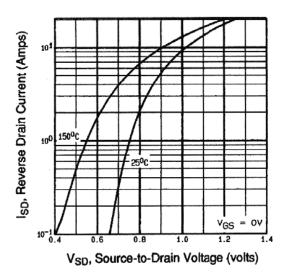


Fig. 7 - Typical Source-Drain Diode Forward Voltage

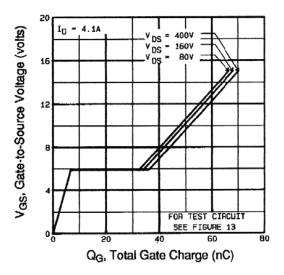


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

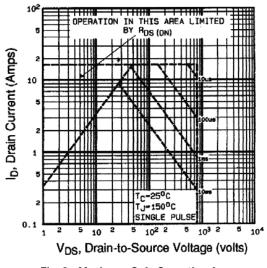


Fig. 8 - Maximum Safe Operating Area



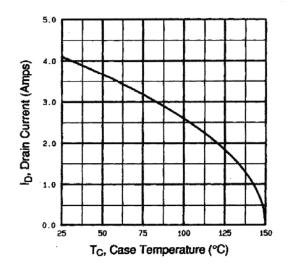


Fig. 9 - Maximum Drain Current vs. Case Temperature

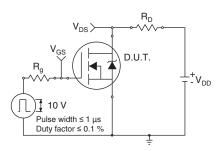


Fig. 10a - Switching Time Test Circuit

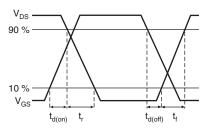
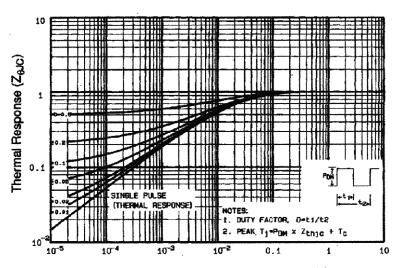


Fig. 10b - Switching Time Waveforms



t<sub>1</sub>, Rectangular Pulse Duration (seconds) Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

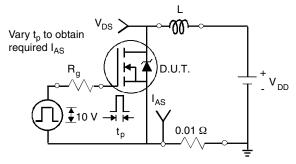


Fig. 12a - Unclamped Inductive Test Circuit

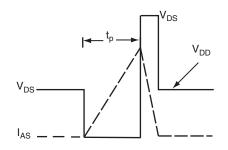


Fig. 12b - Unclamped Inductive Waveforms



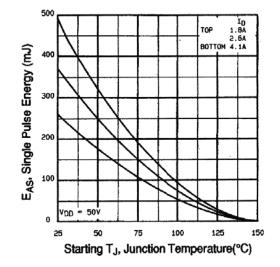


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

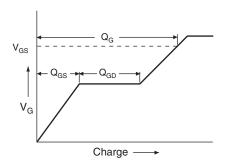


Fig. 13a - Maximum Avalanche Energy vs. Drain Current

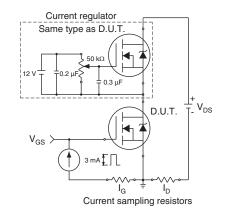
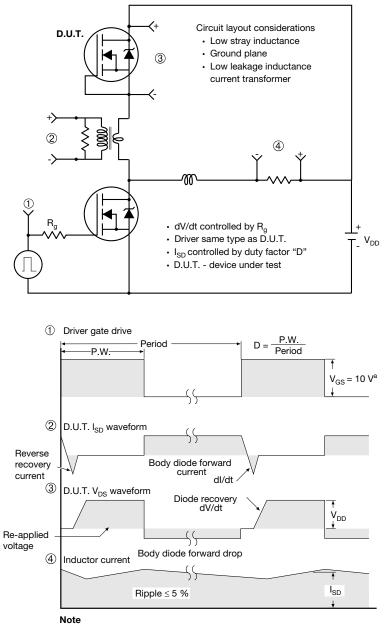


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit

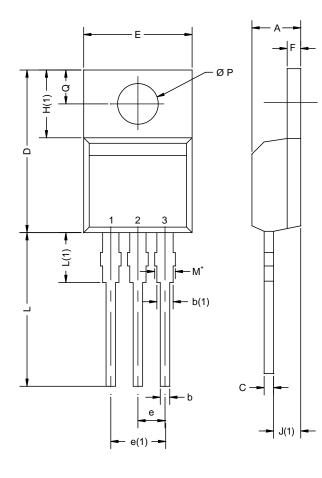


a.  $V_{GS} = 5 V$  for logic level devices

Fig. 14 - For N-Channel



### **TO-220AB**



	MILLIN	IETERS	INCHES		
DIM.	MIN.	MAX.	MIN.	MAX.	
A	4.25	4.65	0.167	0.183	
b	0.69	1.01	0.027	0.040	
b(1)	1.20	1.73	0.047	0.068	
С	0.36	0.61	0.014	0.024	
D	14.85	15.49	0.585	0.610	
E	10.04	10.51	0.395	0.414	
е	2.41	2.67	0.095	0.105	
e(1)	4.88	5.28	0.192	0.208	
F	1.14	1.40	0.045	0.055	
H(1)	6.09	6.48	0.240	0.255	
J(1)	2.41	2.92	0.095	0.115	
L	13.35	14.02	0.526	0.552	
L(1)	3.32	3.82	0.131	0.150	
ØΡ	3.54	3.94	0.139	0.155	
Q	2.60	3.00	0.102	0.118	
ECN: X12-0208-Rev. N, 08-Oct-12 DWG: 5471					

#### Notes

\* M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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